

<b>Notice of References Cited</b>			Application/Control No.	Applicant(s)/Patent Under Reexamination YAMANAKA, TAKASHI	
			Examiner Ryan D. Walsh	Art Unit 2852	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
	D	US-			
	E	US-			
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	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 06064279 A	03-1994	Japan	TSUJII et al.	G03G 15/00
	O	JP 11288142 A	10-1999	Japan	YAMADA et al.	G03G 15/00
	P	JP 20011100576 A	04-2001	Japan	SAITO, KOJI	G03G 15/20
	Q	JP 2001206562 A	07-2001	Japan	YOSHIOKA, KIYOHARU	G03G 15/20
	R	JP 2003228267 A	08-2003	Japan	MIZUGUCHI et al.	G03G 21/16
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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